

## EMRS SYMPOSIUM N

MONDAY 15 SEPTEMBER	
	<b>Structure solution and refinement: Advances &amp; perspectives, Chairs: Wladek Minor, Sven Lidin</b>
09:00	Synchrotron SOLARIS, present status and future development M.J. Stankiewicz <sup>1,2</sup> , C. J. Bocchetta <sup>1</sup> , R. Nietubyc <sup>1,3</sup> , K. Szamota-Leandersson <sup>1</sup> , <u>A. I. Wawrzyniak</u> <sup>1,2</sup> and M. Zającz <sup>1</sup> 1 National Synchrotron Radiation Centre SOLARIS, Jagiellonian Univ., 30-392 Kraków, Poland; 2 Inst. of Physics, Jagiellonian Univ. ul. Reymonta 4, 31-059 Kraków, Poland; 3 Narodowe Centrum Badań Jądrowych, 05-400 Otwock, Świerk, Poland
09:30	Recent advances in crystal structure solution by powder diffraction data <u>Angela Altomare</u> , a Corrado Cuocci, a Anna Moliterni, a Rosanna Rizzi, a Institute of Crystallography CNR, via Amendola 122/o 70126 Bari, Italy
10:00	Beyond the Bragg peaks: Correlation function studies of the structure of materials Alex C. Hannon ISIS Facility, Rutherford Appleton Laboratory, Chilton, Didcot, Oxon OX11, U.K
10:30	<b>Coffee break</b>
	<b>Nanocrystalline and nanoporous materials, Chairs: Jaroslaw Majewski, Michael Knapp</b>
11:00	Crystallography of phase transitions in (Ti,Al)N nanocomposites controlled by microstructure defects David Rafaja Institute of Materials Science, TU Bergakademie Freiberg, Gustav-Zeuner-Str. 5, D-09599 Freiberg, Germany
11:30	Zeilic materials Kenny Stahl Department of Chemistry Technical University of Denmark, 2800 Lyngby, Denmark
12:00	Small metal clusters in catalysis Zbigniew Kaszkur Institute of Physical Chemistry PAS, Warsaw, Poland
12:30	Insights into human dentine nanostructure by combined diffraction and phase contrast-enhanced tomography Paul Zaslansky, Jean-Baptiste Forien, Anke Maerten, Claudia Fleck Julius Wolff Inst. Charité - Universitätsmedizin Berlin; Fachgebiet Werkstofftechnik, Technische Univ Berlin, Germany
12:40	<b>Lunch break</b>
	<b>Functional materials 1, Chairs: Zbigniew Kaszkur, Krystyna Ławniczak-Jabłońska</b>
14:00	In-situ synchrotron and neutron studies on Li-ion battery materials <u>M. Knapp</u> <sup>1</sup> , N. Kiziltas-Yavuz <sup>1</sup> , M. Yavuz <sup>1</sup> , M. Muehlbauer <sup>2,3</sup> 1 Institute for Applied Materials- Energy Storage Systems (IAM-ESS), Karlsruhe Institute of Technology (KIT), Germany; 2 Forschungs-Neutronenquelle Heinz Maier-Leibnitz (FRM II), Technische Universität München, D-85748 Garching b. München, Germany; 3. Material Science, Technische Universität Darmstadt, D-64287 Darmstadt, Germany
14:30	In-situ and ex-situ neutron diffraction experiments on electrode materials for Li-ion batteries <u>Matteo Bianchini</u> <sup>(a,b,c,d)</sup> , Emmanuelle Suard <sup>(c)</sup> , Christian Masquelier <sup>(a,d)</sup> and Laurence Croguennec <sup>(b,d)</sup> (a) Lab. de Réactivité et de Chimie des Solides, CNRS-UMR#7314, Univ. de Picardie Jules Vernes, F-80039 Amiens Cedex 1, France; (b) CNRS, Univ. Bordeaux, ICMCB, UPRI 9048, F-33600 Pessac, France; (c) Inst. Laue-Langevin, 6 rue J. Horowitz, F-38000 Grenoble, France; (d) RS2E, Réseau Français sur le Stockage Electrochimique de l'Energie, FR CNRS#3459, F-80039 Amiens Cedex 1, France
15:00	In-situ XRD studies on the influence of stress on the low-temperature degradation of zirconia ceramics <u>Klaus G. Nickel</u> , Tobias Kiemle, Christoph Berhold, Mike Swain 1 to 3: University of Tübingen, Germany, Faculty of Science, Department of Geosciences, Applied Mineralogy; 4: University of Sydney, Faculty for Dentistry, Australia
15:10	Quantitative study of dislocation densities of friction stir processed in-situ particles reinforced TiB2/AA6063 composites by X-ray line analysis T. Yan, <u>Z Chen</u> , A. Borbély, G Ji, S.Y. Zhong, V. Ji, H.W. Wang a State Key Laboratory of Metal Matrix Composites, Shanghai Jiao Tong University, Shanghai 200240, P R China b SMS Materials Center and CNRS UMR 5146, Ecole des mines de Saint Etienne, 158, cours Fauriel, 42023 Saint Etienne, France c Unité Matériaux et Transformations, CNRS UMR 8207, Université Lille 1, Villeneuve d'Ascq, 59655, France. d CIMMO/LEMHE, UMR CNRS 8182, Université Paris-Sud 11, Orsay Cedex, 91405, France
15:20	Crystallography orientation of Cu-Sn IMC in Cu/Sn-3.5Ag/Cu-xZn microbumps and Zn-doped solder joints <u>Wei Tu</u> , Hsiang-Ching Chang, Jenq-Gong Duh Department of Materials Science and Engineering, National Tsing Hua University, Hsinchu, Taiwan
15:30	<b>Coffee break</b>
	<b>Crystallography at the turn of the millennium, Chairs: John Tse, Matteo Leoni</b>
16:00	X-ray diffraction - toward the future of structural biology <u>Wladek Minor</u> <sup>1,3,4,5,6</sup> , A. Wlodawer <sup>2</sup> , Heping Zheng <sup>1,3,4,5</sup> , Hou Jing <sup>1,3,5,6</sup> , M.D. Zimmerman <sup>1,3,4,5,6</sup> , Marek Grabowski <sup>1,3,4,5,6</sup> 1 University of Virginia, Charlottesville, VA 22903, USA; 2 National Cancer Institute, Frederick, MD 21702, USA; 3 Midwest Center for Structural Genomics, USA; 4 New York Structural Genomics Research Consortium, USA; 5 Center for Structural Genomics of Infectious Diseases, USA 6 Enzyme Function Initiative, USA

16:30	<b>Aperiodic materials: Why and how?</b> Sven Lidin Polymer and Materials Chemistry, Lund University, Box 124, SE-22100 Lund, Sweden
17:00	Quasicrystal structure analysis - goals and limits Walter Steurer Laboratory of Crystallography ETH Zurich Vladimir-Prelog-Weg 5 8093 Zurich, Switzerland
17:30	Ab Initio Random Structure Searching for phase prediction in niobates (ANbO3, A=Li, Na, K, Rb). <u>Anna Kimmel</u> , Chris Pickard National Physical Laboratory, University College London, London, U.K.
17:40	<b>Poster Session (in: Main Hall and Institute of Physics)</b>
	<b>TUESDAY 16 SEPTEMBER</b>
	<b>Diffraction and scattering tools for studies of materials structure, defects and properties, Chairs: Pierre Ruterana, Wieslaw Lasocha</b>
09:00	X-ray and neutron scattering studies of bio-relevant structures: From model lipid membranes to living cell cultures under flow stress Jaroslaw Majewski Los Alamos Neutron Scattering Center, H-805, Los Alamos National Laboratory, Los Alamos, NM, 87545, USA
09:30	Diffraction and phase contrast imaging of defects in crystals J.M Yi <sup>1</sup> , T.S. Argunova <sup>1,2</sup> , and <u>Jung Ho Je</u> <sup>1</sup> 1 X-ray Imaging Center, Department of Materials Science and Engineering, University of Science and Technology, Pohang, South Korea; 2 Ioffe Physico-Technical Institute, RAS, St Petersburg, Russian Federation
10:00	Synchrotron Mössbauer reflectometry: A tool for magnetic thin film analysis Denes Lajos Nagy Wigner Research Centre for Physics of the Hungarian Academy of Sciences, Budapest, Hungary
10:30	<b>Coffee break</b>
	<b>Structure and microstructure analysis using X-ray and electron diffraction, Chairs: Walter Steurer, Jung Ho Je</b>
11:00	Progress in microstructure analysis by diffraction Matteo Leoni DICAM - University of Trento, via Mesiano, 77 - 38123 Trento, Italy
11:30	Structure solution of complex intermetallics using solely electron diffraction data <u>Louisa Meshi</u> , Shmuel Samuha 1) Department of Materials Engineering, Ben-Gurion University of the Negev, Beer-Sheva, Israel 2) Ilse Katz Institute for Nanoscale Science and Technology, Ben Gurion university of the Negev, Beer-Sheva, Israel
12:00	Glancing incidence X-ray diffraction as an efficient tool to probe the structure and the microstructure of polycrystalline thin layers <u>D. Simeone</u> <sup>1</sup> , G. Baldinozzi <sup>1</sup> , J-F Berar <sup>2</sup> 1 CEA/DEN/DANS/DM2S/ LRC CARMEN CEN Saclay France & CNRS/ SPMS UMR8785 LRC CARMEN, Ecole Centrale de Paris, F92292, Chatenay Malabry. 2 Institut Neel, CNRS & Université Joseph Fourier, BP 166, Grenoble Cedex, France
12:10	XRPD study of crystal growth and phase transformations of nanocrystalline oxides <u>Giora Kimmel</u> , Dmitry Mogilyanski, Roni Z. Shneck, Jacob Zabicky Dept of Nucl. Engineering, Ben-Gurion University of the Negev, Beer-Sheva, Israel; Characterization Lab. Center, Ilse Katz Institute for Nanoscale Science & Technology, Ben-Gurion Univ. of the Negev, Beer-Sheva, Israel; Dept of Materials Engineering, Ben-Gurion Univ. of the Negev, Beer-Sheva, Israel; Dept of Chemical Engineering, Ben-Gurion Univ. of the Negev, Beer-Sheva, Israel
12:20	Multiaxial diffraction analysis of highly textured materials: monoclinic HfO2 thin films <u>A. Gómez-Núñez</u> , J. Bassas, A. Vila University of Barcelona, Department of Electronics, Martí i Franques 1, E08028-Barcelona, Spain; University of Barcelona, Scientific and Technological Centers (CCITUB), E08028-Barcelona, Spain; University of Barcelona, Department of Electronics, Martí i Franques 1, E08028-Barcelona, Spain
12:30	Orientation-sensitive growth of graphene on platinum thin films and thermal-assisted transfer of patterned graphene films <u>Jae-Kyung Choi</u> , Jinsung Kwak, Soon-Dong Park, Minbok Jung, Hyung Duk Yun, Seoktae Kang, Dong-Su Lee, Dong-Yeon Park, Suk-Kyung Hong, Sung Youb Kim, <u>Hyung-Joon Shin</u> , and Soon-Yong Kwon School of Materials Science and Engineering, Ulsan National Institute of Science and Technology (UNIST), Korea; School of Mechanical and Nuclear Engineering, Ulsan National Institute of Science and Technology (UNIST), Korea; Dept of Civil Engineering, Kyung Hee University, Korea; G-Mek Incorporation, Korea
12:40	<b>Lunch break</b>
	<b>Electron microscopy as a fine crystallographic tool for semiconductors and other materials, Chairs: Manfred Burghammer, Magali Morales</b>
14:00	Determination of growth polarity by Convergent Beam Electron Diffraction in III-V semiconductors Zuzanna Liliental-Weber Materials Science Division, Lawrence Berkeley National Laboratory, Berkeley, CA 94720, U.S.A.
14:30	The combined topological analysis, atomistic modeling and HRTEM of grain boundaries in wurtzite materials Pierre Ruterana CIMAP UMR 6252, ENSICAEN, 6 Bd Marechal Juin, 14050, Caen, France

15:00	<p><b>Self-ordering on sapphire vicinal surfaces: A study by AFM and GISAXS measurements</b>  <u>Elsa Thune</u><sup>1</sup>, Caroline Matrigne<sup>1</sup>, David Babonneau<sup>2</sup>, Ahmad Fakh<sup>1</sup>, René Guinebretiere<sup>1</sup>  <sup>1</sup> Laboratoire Science des Procédés Céramiques et de Traitement de Surface (SPCTS, UMR CNRS 7315), ENSCI, Centre Européen de la Céramique (CEC), 12 rue Atlantis, 87068 Limoges Cedex, France; <sup>2</sup> Institut PPRIME (UPR CNRS 3346), Université de Poitiers, SP2MI, Téléport 2, Boulevard Marie et Pierre Curie, BP 30179, 86962 Futuroscope Chasseneuil Cedex, France</p>
15:10	<p><b>Structure and crystallography of inclined GaN nanowires using TEM methods</b>  A. Lotsari<sup>1</sup>, G. P. Dimitrakopoulos<sup>1</sup>, Th. Kehagias<sup>1</sup>, A. Adikimenakis<sup>2</sup>, Ph. Komninou, A. Georgakilas<sup>2</sup>  <sup>1</sup>Physics Department, Aristotle University of Thessaloniki, GR 541 24, Thessaloniki, Greece; <sup>2</sup>Microelectronics Research Group (MRG), IESL, FORTH, P.O. Box 1385, 71110 Heraklion Crete, Greece; and Physics Dept, Univ. of Crete, Heraklion Crete, Greece</p>
15:20	<p><b>X-ray and electron diffraction studies in ruby crystals</b>  <u>B.B.Nayak</u>, T.Dash, B.K. Mishra  CSIR-IMMT, Bhubaneswar-751013, India</p>
15:30	<p><b>Coffee break</b></p>
<p><b>Crystallography of novel and functional materials, Chairs: Alex Hannon, Bijanbhari Nayak</b></p>	
16:00	<p><b>New hybrid organic-inorganic materials: Synthesis, structure, applications</b>  <u>Wiesław Lasocha</u><sup>1,2</sup>, Katarzyna Luberd-Dumaś<sup>2</sup>  <sup>1</sup> Fac. of Chemistry, Jagiellonian Univ., Ingardena 3, 30-060 Krakow, Poland; <sup>2</sup> J. Haber Inst. of Catalysis, PAS, 30-239 Krakow, Poland</p>
16:30	<p><b>Applications of real time, high temperature diffraction at MCX@Elettra</b>  <u>Jasper Plaisier</u>, Mahmoud Abdellatif &amp; Andrea Lausi  Elettra – Sincrotrone Trieste, Strada Statale 14 – km 163,5, 34149 Basovizza, Trieste, Italy</p>
17:00	<p><b>Structural analysis of new titanium oxide material exhibiting functionality in the absence of light irradiation</b>  <u>Toshihiro Okajima</u><sup>1</sup>, Toshio Irie<sup>2</sup>, Hiroshi Shirasawa<sup>3</sup>, Kenji Suzuki<sup>4</sup>  <sup>1</sup> Kyushu Synchrotron Light Res. Ctr., Saga 841-0005, Japan; <sup>2</sup> New Catalyst Res.Inst., Funabashi, Chiba 274-0825, Japan; <sup>3</sup> Graduated School of Medicine, Chiba Univ., Chiba, Chiba 263-8522, Japan; <sup>4</sup> Advanced Inst. of Materials Science, Sendai, Miyagi 982-0252, Japan.</p>
17:10	<p><b>Crystal structure peculiarities of the Zr(Ti)3Cr3O compounds and their hydrides</b>  <u>P. Lyutyi</u>, V. Sttender, A. Riabov, I. Zavalii  Karpenko Physico-Mechanical Institute of the NAS of Ukraine, 5 Naukova St., Lviv, 79601, Ukraine</p>
17:20	<p><b>Synthesis of magnetic doped kesterite single crystals</b>  <u>Maciej Białogłowski</u>, Mohammad Fadaghi, Paulina Marek, Grzegorz Matyszcak, Michał Wrzecieć, Sławomir Podsiadło  Faculty of Chemistry, Warsaw University of Technology, Noakowskiego 3, 00-664 Warsaw, Poland</p>
17:30	<p><b>p-type and n-type polycrystalline silicon thin films formed by aluminium induced crystallization and solid phase epitaxy</b>  <u>Mehmet Karaman</u>, Özge Tüzün Özmen, Salar Habibpur Sedani, Raşit Turan  GÜNAM, Middle East Technical University, 06800 Ankara, Turkey; Department of Physics, Düzce University, 81620 Düzce, Turkey; GÜNAM, Middle East Technical Univ., 06800 Ankara, Turkey; Dept of Physics, Middle East Technical University, 06800 Ankara, Turkey</p>
17:40	<p><b>Poster Session (in: Main Hall and Institute of Physics)</b></p>
<p><b>WEDNESDAY 17 SEPTEMBER</b></p>	
09:00	<p><b>Plenary Session - Main Hall</b></p>
12:30	<p><b>Lunch break</b></p>
<p><b>Materials Science - Advanced characterization - PART 1 (Joint with symposia H &amp; J), Chairs: Jean Fompeyrine, Wojciech Paszkowicz, Thilo Glatzel</b></p>	
14:00	<p><b>Reciprocal space meets real space - employing nano-beams for scanning diffraction</b>  T. Dane<sup>1</sup>, E. Di Cola<sup>1</sup>, L. Lardiere<sup>1</sup>, C. Montero<sup>2</sup>, C. Riekel<sup>1</sup>, M. Sztucki<sup>1</sup>, B. Weinhausen<sup>1</sup>, and M. Burghammer<sup>1,3</sup>  <sup>1</sup> European Synchrotron Radiation Facility, Grenoble, France; <sup>2</sup> Université Montpellier 2, Laboratoire de Mécanique et Génie Civil, Montpellier, France; <sup>3</sup> Ghent University, Department of Analytical Chemistry, Ghent, Belgium</p>
14:30	<p><b>Combined refinement of GIXRF, XRR and XRD data in a global approach: analysis of textured In2O3/Ag/ In2O3/Si architectures and III-V based heterostructures</b>  <u>Magali Morales</u>(<sup>1</sup>), L. Lutterotti (<sup>2</sup>), Daniel Chateigner(<sup>2</sup>), Bérenger Caby(<sup>3</sup>), Emmanuel Nolot(<sup>3</sup>), Patrice Gergaud(<sup>3</sup>), G. Pepponi (<sup>4</sup>)  (<sup>1</sup>) CIMAP – ENSICAEN, 6 b Mar-I Juin, 14050 Caen Cedex 4 (<sup>2</sup>) CRISMAT ENSICAEN, 6 bd du Mar-I Juin, 14050 Caen Cedex 4 (<sup>3</sup>) CEA Grenoble, 17 rue des Martyrs, 38054 Grenoble Cedex 9 (<sup>4</sup>) Fondazione Bruno Kessler – Via S.Croce 77, 38122 Trento, Italie</p>
15:00	<p><b>Aberration-corrected atomic-resolution electron microscopy for advanced materials characterization</b>  Rolf Erni  Electron Microscopy Center, Empa, Swiss Federal Labs for Materials Science and Technology, Dübendorf, Switzerland</p>
15:30	<p><b>Coffee break</b></p>
<p><b>Materials Science - Advanced characterization - PART 2 (Joint with symposia H &amp; J), Chairs: Jean Fompeyrine, Wojciech Paszkowicz, Thilo Glatzel</b></p>	
16:00	<p><b>Local probing and writing with helium ions</b>  <u>E. van Veldhoven</u><sup>1</sup>, D. J. Maas<sup>1</sup>, G. Nanda<sup>2</sup>, P.F.A. Alkemade<sup>2</sup>  <sup>1</sup> TNO, Nano-instrumentation, Delft, Netherlands <sup>2</sup> Delft Univ. Technol, Kavli Inst. of Nanoscience, Delft, The Netherlands</p>
16:30	<p><b>Investigation of photovoltaic and photo-catalytic materials by surface photovoltage techniques</b>  Thomas Dittlich  Helmholtz Center Berlin for Materials and Energy, Hahn-Meitner-Platz 1, 14109 Berlin, Germany</p>
17:00	<p><b>Hall effect metrology for ultra-thin semiconducting layers</b>  <u>Dirch H. Petersen</u>, Henrik H. Henriksen, Rong Lin, Peter F. Nielsen, Ole Hansen  Department of Micro- and Nanotechnology, Technical University of Denmark, DTU Nanotech, Building 345E, DK-2800 Kongens Lyngby, Denmark ; CAPRES A/S, Scion-DTU, Building 373, DK-2800 Kongens Lyngby, Denmark</p>

17:30	<p><b>Break</b></p>
18:00	<p><b>Best Presentation Awards Ceremony and Reception - Main Hall</b></p>
<p><b>THURSDAY 18 SEPTEMBER</b></p>	
<p><b>Synchrotron tools: Present and future opportunities, Chairs: Izabela Sosnowska, Kenny Stahl</b></p>	
08:50	<p><b>Characterizing nano-precipitates in steels using in-house SAXS and SANS</b>  <u>M. Ohnuma</u><sup>1</sup>, M. Furusaka<sup>1</sup>, B.S. Seong<sup>2</sup>, J.Suzuki<sup>3</sup>, T.Ishida<sup>1</sup>, R.Hashimoto<sup>1</sup>  <sup>1</sup> Hokkaido University, 5 Chome Kita 8 Jonishi, Kita Ward, Sapporo, Hokkaido 060-0808, Japan; <sup>2</sup> Korea Atomic Energy Research Institute, 989-111, Daedeokdaero, Yuseong-gu, Daejeon, 305-353, Rep. of Korea; <sup>3</sup> Comprehensive Res. Organization for Science and Society (CROSS), Tokai, Ibaraki 319-1106, Japan</p>
09:00	<p><b>Quantitative XRD analysis, a tool for the quality control of clinker and cements</b>  L. Leon-Reina(a), A. G. De la Torre(a) and M. A. G. Aranda(b)  (a)Universidad de Málaga, Málaga, Spain; (b)CELLS-ALBA synchrotron, Barcelona, Spain</p>
09:30	<p><b>New facility for long duration experiments at Diamond synchrotron source</b>  <u>Claire A. Murray</u>, Paul Adamson, Sarah Day, Stephen P. Thompson, Jonathan Potter &amp; Chiu C. Tang  Diamond Light Source, Harwell Science and Innovation Campus, Didcot, Oxfordshire OX11 0DE, United Kingdom</p>
10:00	<p><b>100 years on. Farewell experimental crystallography?</b>  W I F David  ISIS Facility, Rutherford Appleton Laboratory, OX11 0QX, UK; Inorganic Chemistry Lab., Univ. of Oxford, OX1 3QR, UK</p>
10:30	<p><b>Coffee break</b></p>
<p><b>Functional materials 2, Chairs: Denes Nagy, Krzysztof Wozniak</b></p>	
11:00	<p><b>Physical properties of complex metallic alloys in relation to crystal structures</b>  Janez Dolinšek  J. Stefan Institute, University of Ljubljana, Jamova 39, SI-1000 Ljubljana, Slovenia</p>
11:30	<p><b>Crystallographic features and chemical bonding in thermoelectric materials</b>  Yuri Grin  Max-Planck-Institut für Chemische Physik fester Stoffe, Dresden, Germany</p>
12:00	<p><b>Growth of SnS2 single crystals for single-layer exfoliation</b>  Maciej Białogłowski, Mohammad Fadaghi, Paulina Marek, Grzegorz Matyszcak, Michał Wrzecieć, Sławomir Podsiadło  Warsaw Univ. of Technology, Noakowskiego 3, 00-664 Warsaw, Poland</p>
12:10	<p><b>The investigation of the structure of bulk metallic glasses before and after laser welding</b>  Virginia Pilarczyk  Silesian University of Technology, The Faculty of Mechanical Engineering, Institute of Engineering Materials and Biomaterials, 18a Konarskiego Street, 44-100 Gliwice, Poland</p>
12:20	<p><b>Magnetic quantum dots formed in semiconductor – structural and magnetic properties as resulted from X-ray absorption study</b>  Krystyna Lawniczak-Jablonska  Institute of Physics, PAS, al. Lotnikow 32/46, 02 668 Warsaw, Poland</p>
12:40	<p><b>Lunch break</b></p>
<p><b>Crystallography and physics of materials formed at high pressures, Chairs: Andre Authier, David Rafaja</b></p>	
14:00	<p><b>Unexplored universe of high-pressure materials</b>  Andrzej Katrusiak  Faculty of Chemistry, A.Mickiewicz Univ., Umultowska 89b, 61-614 Poznan, Poland</p>
14:30	<p><b>Structure and charge density in high pressure solids</b>  John S. Tse  University of Saskatchewan, Saskatoon, Canada</p>
15:00	<p><b>Exploring the properties of materials using high-pressure x-ray diffraction: Recent advances and future challenges</b>  D. Errandonea  Dept Física Aplicada, Universitat de Valencia, 46100 Burjassot (Valencia), Spain</p>
15:30	<p><b>Coffee break</b></p>
<p><b>Crystallography: Its past, present and future, Chairs: W.I.F. David, Angela Altomare</b></p>	
16:00	<p><b>Fifty years of Time-of-Flight (TOF) neutron diffraction at pulsed neutron sources</b>  I.M. Sosnowska  University of Warsaw, 00-691 Warsaw, Hoza 69, Poland</p>
16:30	<p><b>X-ray structural analysis century after the Braggs - success or failure?</b>  Krzysztof Wozniak  Chemistry Department, University of Warsaw, Pasteura 1, 02-093 Warszawa, Poland</p>
17:00-17:30	<p><b>Early days of X-ray diffraction – first applications to material science</b>  André Authier  Institut de Minéralogie, de Physique des Matériaux et de Cosmochimie, Univ. P &amp; M. Curie, France</p>